

**Search Notes**

Application/Control No.

10/760,310

Examiner

Filip Zec

Applicant(s)/Patent under  
Reexamination

HSIEH, HSIN-MAO

Art Unit

3744

**SEARCHED**

Class	Subclass	Date	Examiner
62	3.2,3.62 457.9	8/4/2005	FZ

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	8/4/2005	FZ